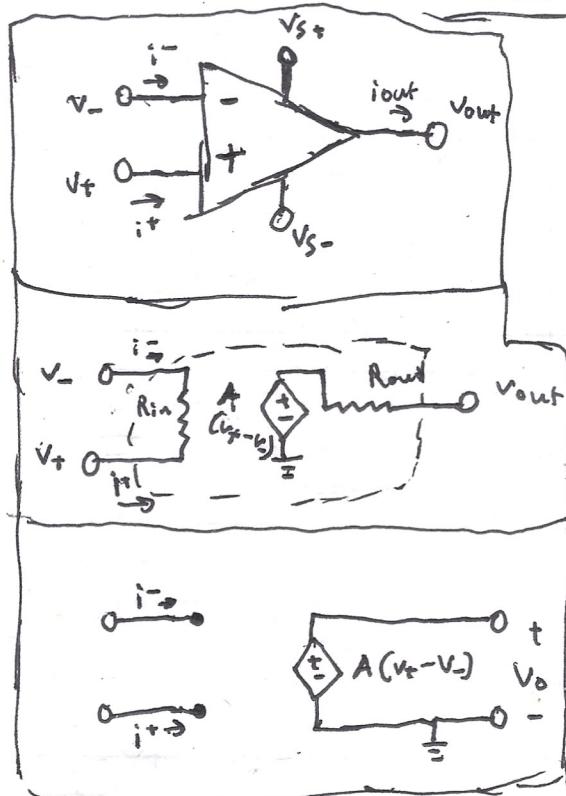
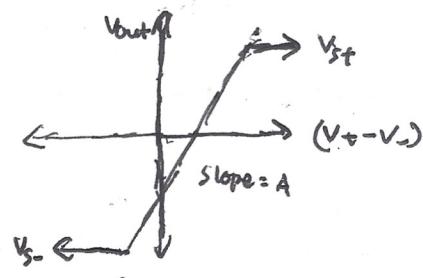


Ideal Op-Amp~~Ideal Model~~

Typical Parameters

$$A = 10^4 \quad V_{S+/-} = 10V$$

$$(V_+ - V_-) = \pm 1mV$$



Neg. Linear Pos.
Saturation Saturation

To maintain linear region,
we use negative feedback.

Ideal Op-Amps:

$$R_i = \infty$$

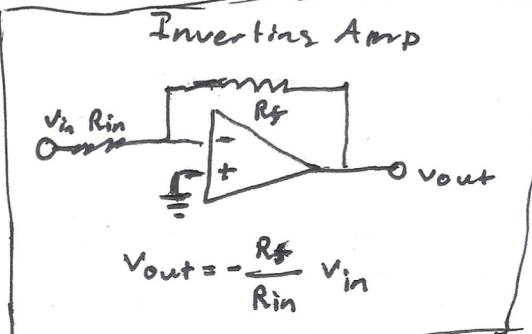
$$A = \infty$$

$$R_o = 0$$

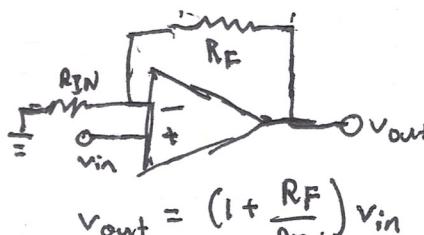
$$i_- = i_+ = 0$$

$$V_- = V_+$$

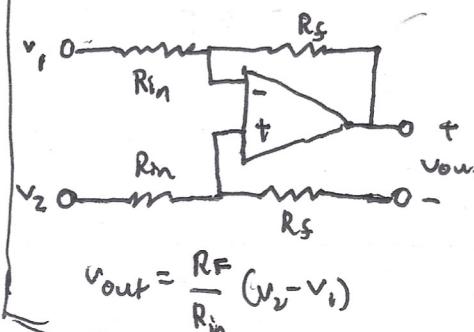
Inverting Amp



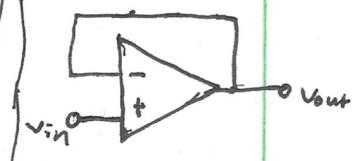
Non Inverting Amp



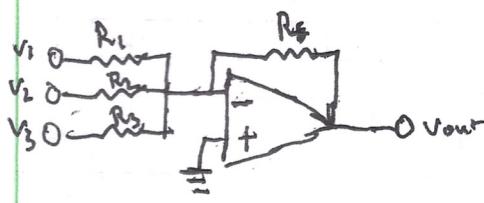
Differential Amp



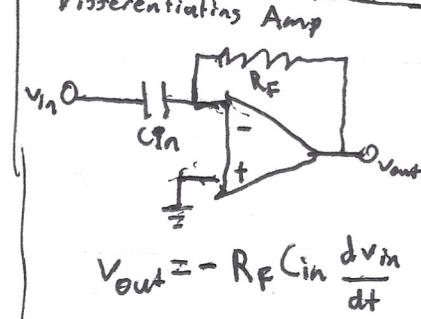
Voltage Follower
(High Imp. buffer)



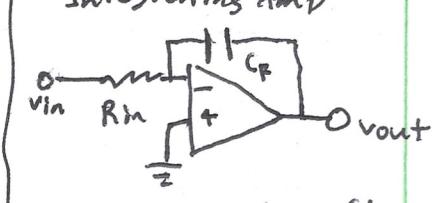
Summing Amp



Differentiating Amp



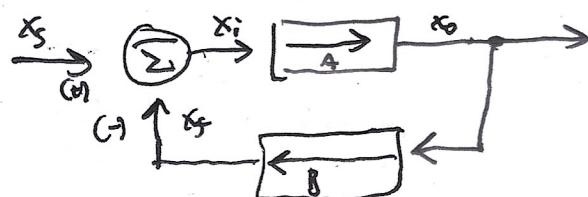
Integrating Amp



$$V_{out} = -R_f \left(\sum V_i / R_i \right)$$

$$V_{out} = -R_f C_{in} \frac{dV_{in}}{dt}$$

$$V_{out} = -\frac{1}{R C_f} \int_0^t V_{in}(t') dt'$$

Feedback Loops

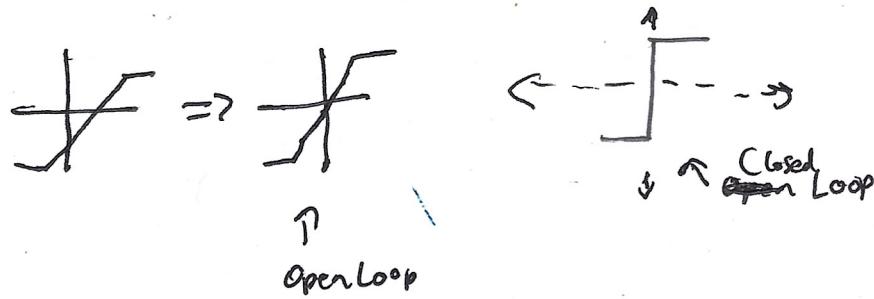
$$x_o = Ax_i \quad x_f = \beta x_o$$

A = open-loop gain β - feedback factor

$$x_i = x_s - x_f \Rightarrow \text{Closed-loop gain: } A_f = \frac{x_o}{x_s} = \frac{A}{1 + AB}$$

$$AB \gg 1 \Rightarrow A_f = \frac{1}{\beta}$$

To use offset correction, a differential amp is used.

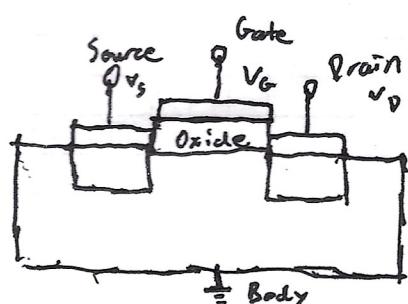


$$\begin{aligned} (v_t - v_-) &\ll \text{ semi ideal } v_t - v_- = 0 \\ A \approx 10^4 & \quad (v_t - v_-) \ll A \rightarrow \infty \\ R_o &\ll A \approx 10^4 \quad R_o = 0 \\ v_{in} &\quad R_o = 0 \quad i_- = i_+ = 0 \\ &\quad i_- = i_+ = 0 \end{aligned}$$

In freq. dep. analysis replace everything with the impedance.

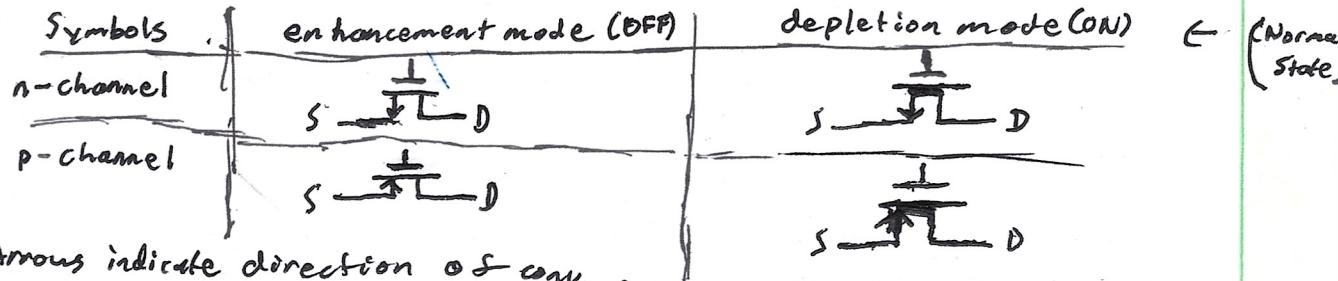
Field Effect Transistors

* Review 2K1 Chpt 13 on basics over n-channel enhancement mode MOSFETs.

Creation of a MOSFET

The wells will be doped and the silicon substrate will be doped oppositely.
Source is usually slightly more doped.

- undoped = excess electrons aka electrons = charge carriers (Usually P-doped)
- P-doped - excess holes aka holes = charge carriers (Usually B-doped)
- Some mosfets will have a channel between the two wells with the same doping (depletion mode).
- A layer of oxide separates the gate and substrate that is insulating, meaning $I_G = 0$ can be assumed.



(Arrows indicate direction of conv. current flow).

Ideal MOSFET

$$V_{th} = \text{Threshold Voltage} \Rightarrow n\text{-ch. enh. + p-ch. dep.} = V_{th} > 0 \\ p\text{-ch. dep. + n-ch. enh.} = V_{th} < 0$$

To turn on enh. mode MOSFETs, Gate must be polarized opposite to charge carriers ($+V_{GS}$ for n, $-V_{GS}$ for p).

To turn off dep. mode MOSFETs, Gate-Source must be polarized same to charge carriers ($-V_{GS}$ for n, $+V_{GS}$ for p).

(Most of the times body + source are @ same potential), transistors are driven by volt. diff. between Gate + Body.

The Gate operates like a capacitor w/ capacitance rep. as C_{ox} .

All ~~current~~ voltage

$$\text{Cutoff} \approx V_{GS} \leq V_{th} \text{ for n-ch.}$$

$$V_{GS} \geq V_{th} \text{ for p-ch.}$$

Ideal MOSFETs contd

Triode-Sat. Boundary $V_{DS(\text{sat})} = V_{GS} - V_{Th}$ or $V_{GD} = V_{Th}$

* $V_{DS} < V_{DS(\text{sat})} = \text{Triode Region}$

- Complete channel connects Source + Drain
x Length = L, Cross Sec. Area = A
- V_{DS} and I_D are linearly related, the ohmic/linear/triode region of a transistor.

$$x R = \frac{\rho L}{A}, \rho \text{ depends on channel and charge concentration}$$

* $V_{GS} \geq V_{GS(\text{sat})} = \text{Saturation Region}$

- Channel pulls back from drain making R $\uparrow\uparrow$.
- V_{DS} will be high enough to allow charge to still flow
- I_D is ideally indep. from V_{DS} .

Ineq. Slipped for p-channels. + Must not be in Cutoff for these regions to be reached.

k_n/k_p - fixed parameters of a transistor for n/p channel MOSFET.

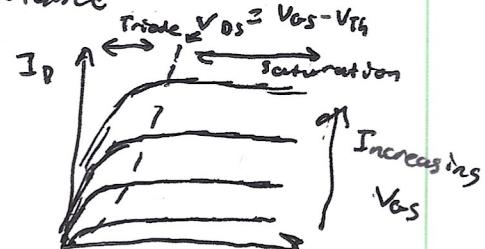
$k_n = \mu C_{ox} \frac{W}{L}$ μ - charge mobility, W/L - width + length of channel
(units $\frac{mA}{V^2}$) (^{use} _{Above eqn}) C_{ox} - Oxide layer capacitance

These are 1st order approx

$$I_D(\text{triode}) = k_n (V_{GS} - V_{Th}) V_{DS} - \frac{V_{DS}^2}{2}$$

$$I_D(\text{saturation}) = k_n \frac{(V_{GS} - V_{Th})^2}{2} = k_n \frac{V_{GS}^2}{2}$$

$$I_D(\text{cutoff}) = 0$$

Solving

1. I_D vs V_{GS} + V_{DS} (control voltages)
2. Use KVL, writing I_D as a func. of control voltages
3. Assume Saturation first.
4. Utilize $I_A = 0$ for KVL.

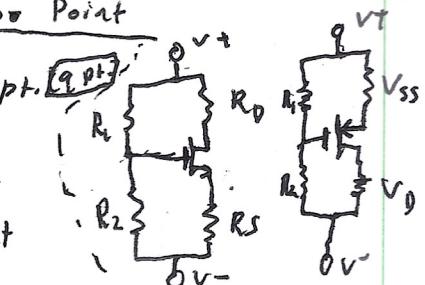
Designing Op-Point

To obtain operating pt.

of CV_{DS} , I_D w/

4 resistors \rightarrow

We want this point



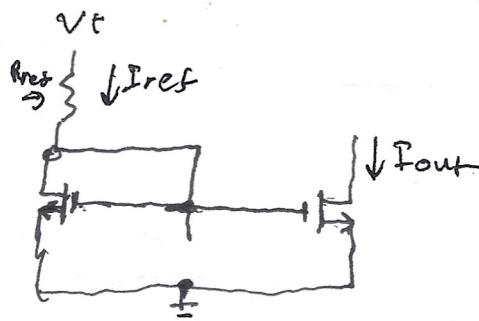
to be at $(V_{DS(\text{max})}, I_{D(\text{max})})$ or the mid. of each pack.

the load line. Then Derive V_{GS} and use KVL to find V_G . $I_A = 0$ so use $R_1 + R_2$ for Voltage divider

to set V_G . $R_1 + R_2$ should both be big so that power is dissipated.

$$I_D(\text{max}) = \frac{V_T - V_S}{R_1 + R_2}$$

$$V_{DS(\text{max})} = V_T - V_S$$

Indep. Current Source

$$M_1 = M_2$$

$$I_{out} = I_{res}$$

Choosing R_{res} will change I_{res}/I_{out}
w/ diff channel parameters

$$k_m n_1 \neq k_m 2 \Rightarrow I_{out} = \alpha I_{REF}$$

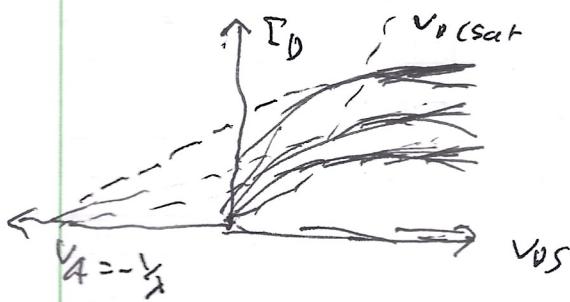
Channel Length Modulation

- Non-ideality of drain current, $I_{D(sat)}$ is not truly indep. of V_{DS} . As V_{DS} continues to increase past $V_{DS(sat)} = V_{DS} - V_{Th}$, the channel will draw back further from the drain.

$$\begin{aligned} I_{D(sat)} &= \frac{k}{2} k_n (V_G - V_{Th})^2 (1 + \lambda |V_{DS} - V_{DS(sat)}|) \\ &= \frac{k}{2} k_n V_{DS(sat)}^2 (1 + \lambda |V_{DS} - V_{DS(sat)}|) \end{aligned}$$

where λ is
the ch. parameter

$I_D - V_{DS}$ graph



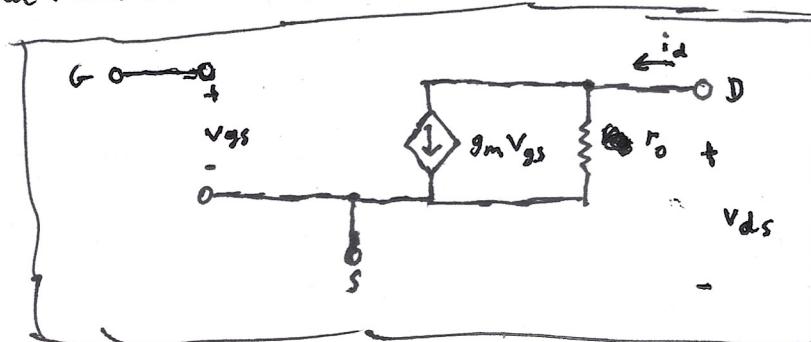
Extrapolating the saturation current lines backward should cause them to intersect @ $I_D = 0$,

$$V = -\frac{k}{\lambda} = V_A \quad (\text{Early Voltage})$$

This results in an output resistance we need to account for.

FET Small-Signal Model
-Mid Frequency

- This model is useful for most frequencies, aka the mid-frequency model.
- It's useful for modeling MOSFETs with AC Voltage & Currents.
- AC model components are highly dependent on DC op. pt.
- We need to compute g_m and r_o to characterize this model and transistor amplifier circuits.



$r_o \approx \infty / \text{open}$
if no drain is present.

Transconductance - g_m

$$g_m = \frac{i_d}{v_{gs}} = \frac{\partial I_D}{\partial V_{GS}}$$

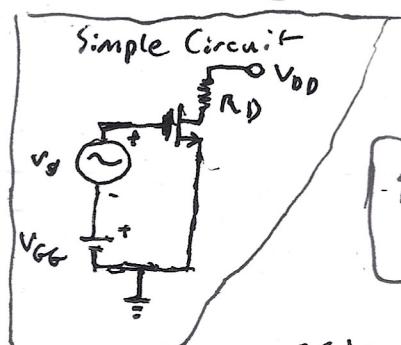
$$\Rightarrow g_m = k_n (V_{GS} - V_{Th}) = \sqrt{2k_n I_D}$$

~~($i_d \propto V_{GS}$)~~

This is derived assuming $V_{GS} = V_{GS} + v_{gs} \approx V_{GS}$
The same assumption is used for current.

i_d has a transconductance that varies with $\sqrt{I_D}$ - DC quiescent current.

Using the load line mentioned before, AC input will move back & forth from open-circuit voltage ($V_{oc} = V_{DD}$) and the short-circuit current (here, $I_{sc} = \frac{V_{DD}}{R_D}$).



$$i_d = k_n (V_{GS} - V_{Th}) v_{gs} + \frac{1}{2} k_n v_{gs}^2$$

$$\begin{aligned} i_d &= \frac{1}{2} k_n (V_{GS} - V_{Th})^2 \\ &= \frac{1}{2} k_n (V_{GS} - V_{Th})^2 + k_n (V_{GS} - V_{Th}) \frac{V_{GS}}{2} \\ &= I_D + i_d \end{aligned}$$

$v_{gs} \ll V_{GS} - V_{Th}$ for small signal models & maintains linear model.
($|v_{gs}| < 0.2(V_{GS} - V_{Th})$)

$$\Rightarrow i_d \approx k_n (V_{GS} - V_{Th}) v_{gs}$$

(Circuit) $\Rightarrow (1 + \lambda)(V_{GS} - V_{GS(\text{sat})}) + \lambda (V_{GS} - V_{GS})$

Param for AC

$$r_o = \frac{\partial V_{DS}}{\partial I_D} = \frac{1}{\lambda I_D}$$

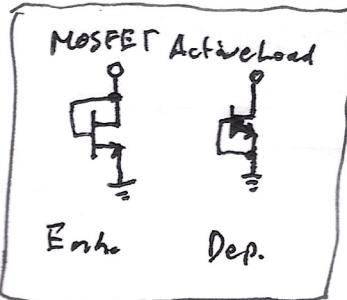
Output Resistance - r_o Internal Output Res. \downarrow w/ λI_D (De-coupling)MOSFETs as Active Loads

Replacing a Resistor with a transistor to reduce DC voltage drop with a high small signal AC Impedance.

Slope of $I-V$ = Inverse of AC resistance $\lambda \downarrow = r_o \uparrow$

Mos + MOSFETs $r_o = 10-100s \text{ k}\Omega$ sometimes larger too.

This means small variations in output voltage shouldn't affect output current. Smaller $I-V$ slope = larger v_{GS} swings allowed before large i_d . Large i_d increases chance that we move to edges of the load line, either i_p peak or $i_p = \text{triode region}$ or $i_{min} = \text{cutoff region}$



\Leftarrow This setup ensures MOSFETs don't reach cutoff.

This also means $I_D = 0 \Rightarrow V_{DS} = 0$

This implies $v_{GS} = 0$ at all times from the dep. mode model, meaning it will act like a resistor of $r_o \Omega$ in mid-freq. Small signal models.

This is bc. the curr. source model will result in 0 curr. only leaving the resistor.

AC Analysis

1. Replace coupling bypass capacitors w/ shorts.
2. All DC Sources = 0
3. Replace MOSFET w/ small signal equiv.

Amplifier Circuits

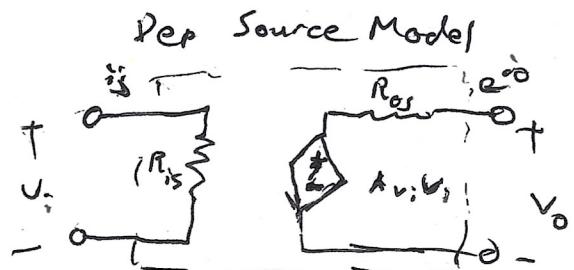
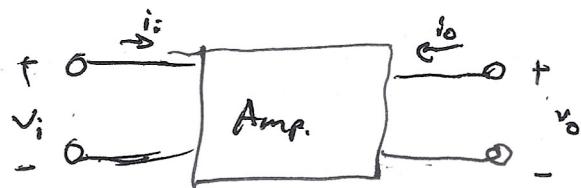
Black box interpretation:

$$A_{Vi} = \frac{V_o}{V_i}$$

$$A_{i_i} = \frac{i_o}{i_i}$$

$$R_{is} = \frac{V_i}{i_i} \quad i_{o_0} = 0$$

$$R_{os} = \frac{V_o}{i_o} \quad V_{i_0} = 0$$

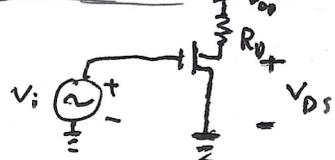


Intrinsic V gain of a MOSFET

$$M_S = g_m r_0 = \frac{1}{\lambda} \sqrt{\frac{2kn}{ID(\text{sat})}}$$

Common Source Amp

Simple CS Amp.



To ensure 3-point stability we will use coupling capacitors (for AC w/o charges DC bias) and bypass capacitors (for AC curr to set around resistors)

To solve for Amps.:

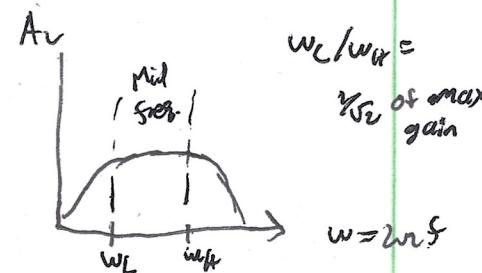
Separate into DC + AC circuits.

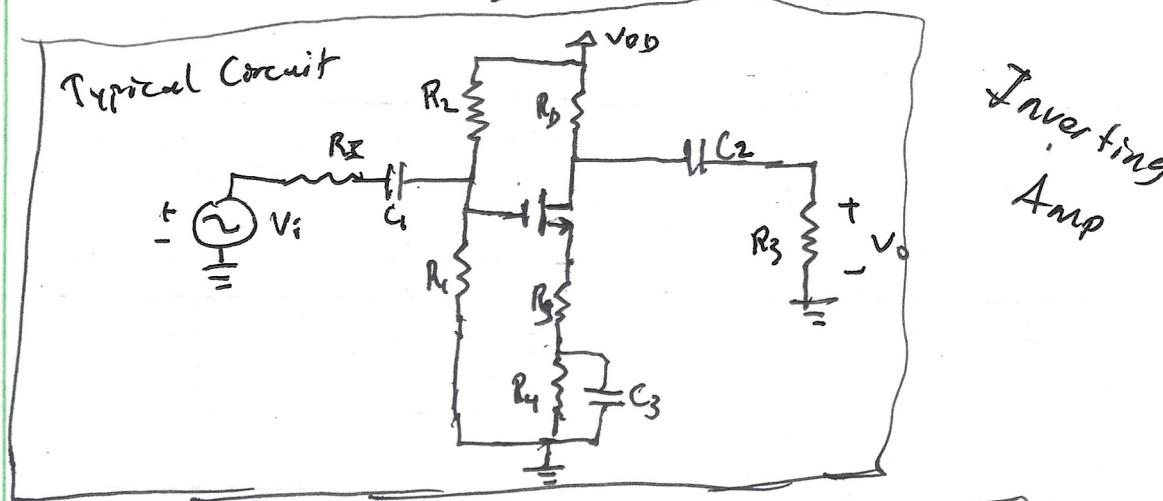
DC Circuit:

1. Capacitors = Open
 2. Inductors = Short
 3. Deactivate AC Sources
4. Find Q-Point:

AC Circuit:

1. Capacitors = Short (@ op freq.)
2. Inductors = Open (@ op freq.)
3. DC V Sources = Deactivate/Short
4. DC I Sources = Deactivate/Open
5. Transistor \Rightarrow Small Signal Model
6. Analyze AC Response

When $A_V \ll R_L$, we can ignore r_o .You can calc. A_V from $\frac{V_g}{V_i}$ and $\frac{V_o}{V_g}$ 

Common Source Amp contd

$$A_v = -\frac{g_m R_L}{1 + g_m R_S} \left(\frac{R_G}{R_P + R_G} \right) \quad R_{in} = \infty, R_{out} = R_L$$

where $R_L = E_g R_{es}$ from Drain to Ground in AC

and $R_G = E_g R_{es}$ from Gate to Ground in AC

To Calc R_C , use R_{eq} from AC model ~~(remove independent sources, other Cs)~~

~~R_C~~

$$\omega_{C_1} = \frac{1}{(R_1 + R_2) C_1}, \quad \omega_{C_2} = \frac{1}{(R_3 + R_4) C_2}, \quad \omega_{C_3} = \frac{1}{(\frac{1}{g_m} R_{SS}) C_3}$$

$$\omega_L = \max(\omega_{C_1}, \omega_{C_2}, \omega_{C_3})$$

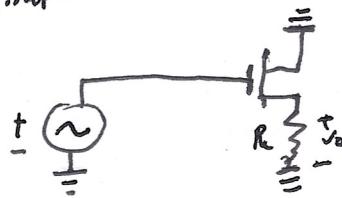
Turns off
indep sources

+
(remove
other Cs)

ω units - rad/s

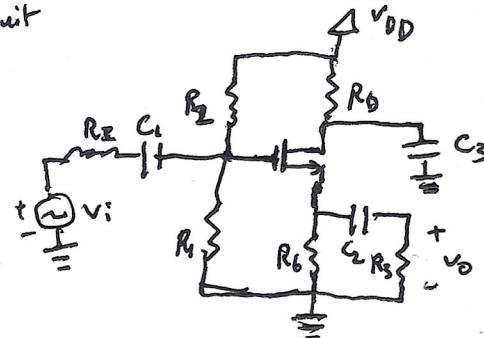
Common Drain Amp

Simple Circuit



Follower Circuit

Typical Circuit



$$A_v = \frac{g_m R_L}{1 + g_m R_L} \left(\frac{R_f}{R_f + R_L} \right) \approx \frac{R_f}{R_f + R_L}$$

$$R_{in} = \infty$$

$$R_{out} = \frac{1}{g_m}$$

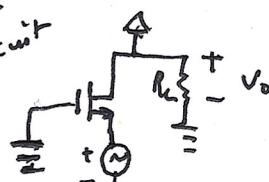
$$\omega_{C_1} = \frac{1}{R_I + R_1 \parallel R_2}, \quad \omega_{C_2} = \frac{1}{(R_3 + R_6 \parallel \frac{1}{g_m}) C_2}$$

$$\omega_L = \max(\omega_{C_1}, \omega_{C_2})$$

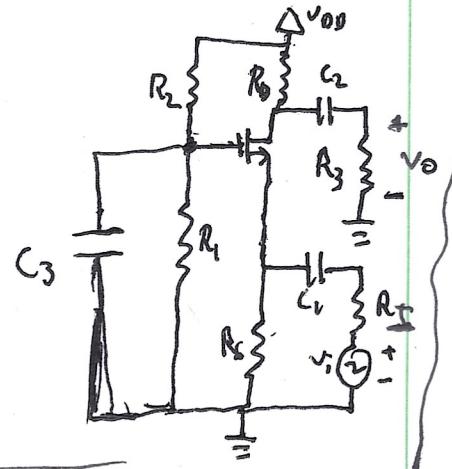
(C_3, R_7) not always included

Common Gate Amp

Simple Circuit

Non Inverting
Non Inverting
Non Inverting

Typical Circuit



$$A_v = \frac{g_m R_L}{1 + g_m (R_I \parallel R_f)} \left(\frac{R_f}{R_I + R_f} \right)$$

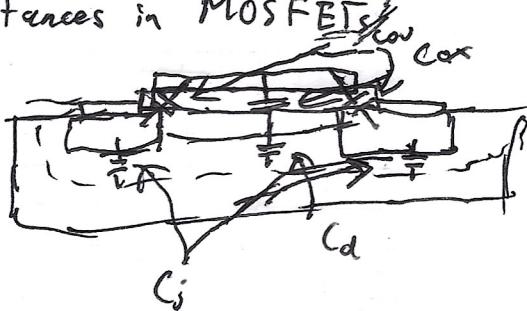
$$R_{in} = \frac{1}{g_m} \quad R_{out} = R_L$$

$$\omega_{C_1} = \frac{1}{(R_B + R_6 \parallel (\frac{1}{g_m})) C_1}, \quad \omega_{C_2} = \frac{1}{(R_D + R_3) C_2}, \quad \omega_{C_3} = \frac{1}{R_1 \parallel R_2 C_3}$$

$$\omega_L = \max(\omega_{C_1}, \omega_{C_2}, \omega_{C_3})$$

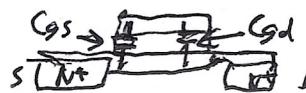
High Freq. Cutoff

Capacitances in MOSFET



$$C_{ox} = C_{gs} + C_{gd}$$

w_4 is defined by C_{gs} and C_{gd} .



Gate to Channel Capacitance:

$$C_{gs}(F) = WL C_{ox}$$



$$C_{gs} = \frac{2}{3} C_{gc} + C_{gso} x_{so}$$

$$C_{gd} = C_{gdo} x_{do}$$

C_{gs} will connect Gate+Source in AC model.

$$R_{w4} = \frac{1}{R_{C_{gs}} C_{gs}}$$



Max Linear Freq (Index of System)
Based on MOSFET

$$f_T = \frac{1}{2\pi} \frac{g_m}{C_{gc}} = \frac{1}{2\pi} \frac{M}{L^2} (V_{ss} - V_T)$$

C_{gs} can be replaced w/ any parallel capacitance to the curr. Source.

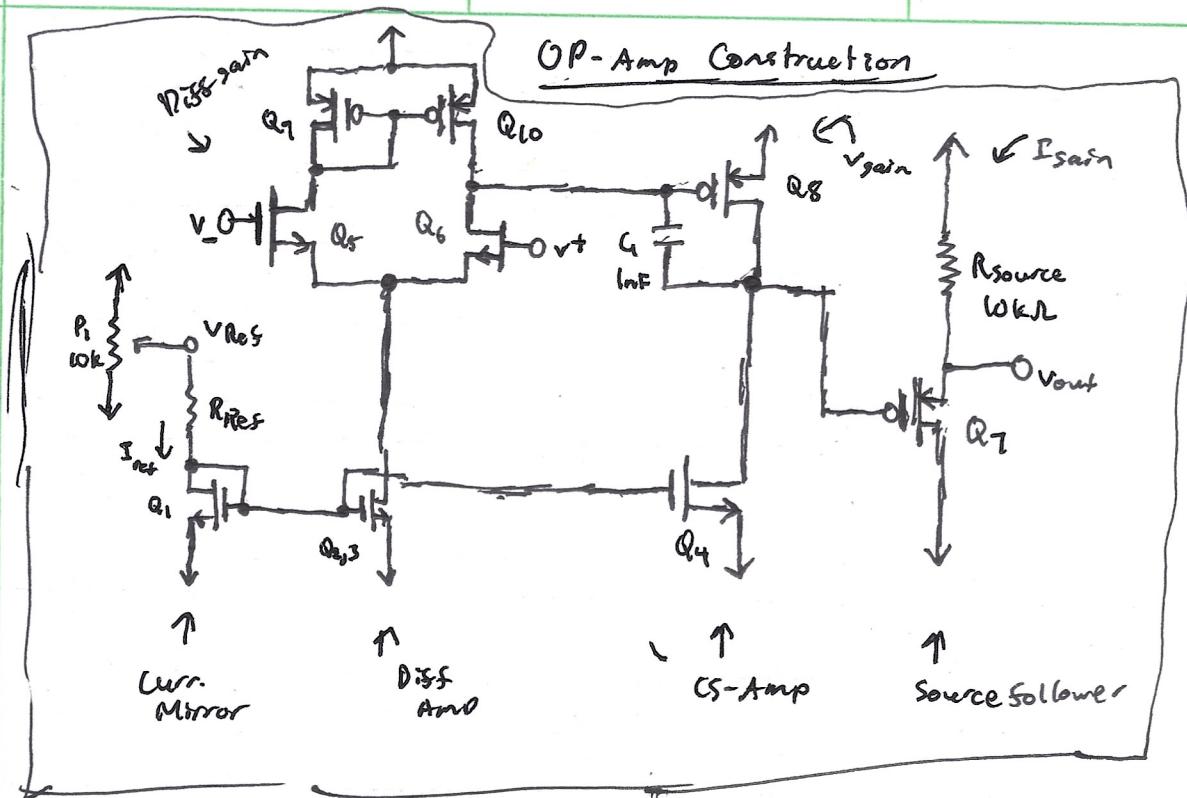
aka Capacitance connecting

G-D, G-S, G-D

~~Storage + Input + Output Capacitance~~

M-Channel Mob. L - Channel Len.

Sum $C_{gs} + C_{gd}$ & in denom,
and take min vs C_{gs}/C_L freq.



Can Explain!

ODEs for RL & RC Circuits

(Series)

First order Circuits:

- RL Circuit: $V_L = L \frac{di_L(t)}{dt} \Rightarrow v_{in}(t) = L \frac{di_L(t)}{dt} + R i_L(t)$ (Derived from KVL)
- RC Circuit: $V_C = C \frac{dv_C(t)}{dt} \Rightarrow v_{in}(t) = R C \frac{dv_C(t)}{dt} + V_C(t)$
- Use KVL or KCL to determine relations and find homogeneous + particular solutions, use conditions to solve for A+B + add them together. Then plus the variable value in the inductor/capacitor voltage equation.
- λ refers the natural frequencies.

ODEs for RC Circuits(Initials: $e^{j\theta} = \cos(\theta) + j\sin(\theta)$)

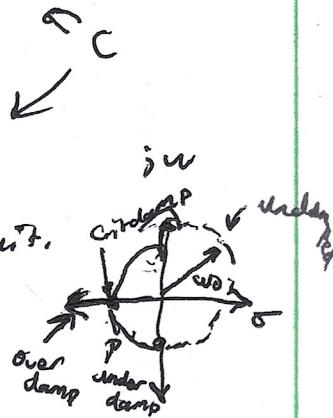
- LC Circuit: $i_L = L \frac{di_L(t)}{dt}$ $i_C = C \frac{dv_C(t)}{dt} \Rightarrow v_L(t) = L C \frac{d^2 v_C(t)}{dt^2}$
- Use same starts as before

ODEs for RLC Circuits

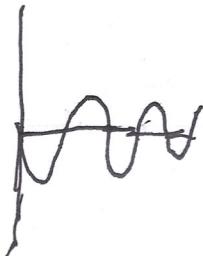
- RLC Circuit: $v_{in}(t) = R C \frac{dv_C(t)}{dt} + L C \frac{d^2 v_C(t)}{dt^2} + v_L(t)$

$$\frac{dv_{in}(t)}{dt} = R \frac{di_L(t)}{dt} + L \frac{d^2 i_L(t)}{dt^2} + \frac{1}{C} i_L(t)$$

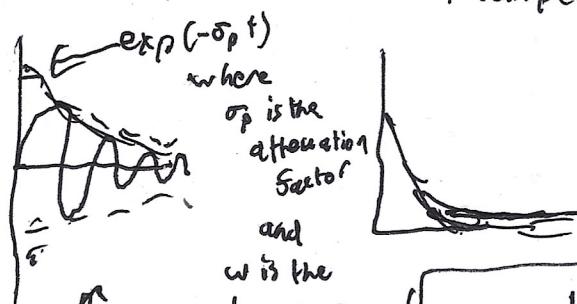
- Damping is done by adding resistors to an LC circuit.
- Over damping = Frequencies are real + distinct
- Critically damped = Frequencies are real + equal
- Under damping = Frequencies are complex



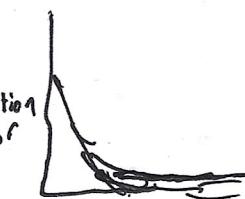
Undamped:



Under damped:



Critically damped



Over damped



Root:

 $-\sigma_p \pm j\omega_d$
 gives center
of oscillation.

$$\omega_0 = \frac{1}{\sqrt{LC}}$$

$$\omega_d = \sqrt{\omega_0^2 - \sigma_p^2}$$

Switched Circuits

We know $R_L + R_C$ circuits gen sol. $\Rightarrow x(t) = x(\infty) + [x(t_0) - x(\infty)] e^{-\frac{(t-t_0)}{\tau}}$

$\tau = RC$ or $\frac{L}{R}$ where $x(t)$ can be i_L or v_C

given $x(t_1) = x_1$ $x(t_2) = x_2$ we can find the time between
two states:

$$t_2 - t_1 = \tau \ln \left[\frac{x_1 - x(\infty)}{x_2 - x(\infty)} \right]$$

• Steps:

- Determine $t_1 \leq t \leq t_2$ (time range)
- Find $x(0)$, $x(\infty)$, R_L , C , Voltages at t_1 & t_2 .
- Plug into solution, plug ~~solution~~ values into time equation to
find $t_2 - t_1$!

Function Transform

- Unit Step Function: $u(t) = \begin{cases} 0 & t < 0 \\ 1 & t \geq 0 \end{cases}$
- Rectangular Function: $c(t) = \begin{cases} 0 & t < t_1 \\ 1 & t_1 \leq t \leq t_2 \\ 0 & t > t_2 \end{cases} = u(t-t_1) - u(t-t_2)$
- Unit Impulse Dirac Function:
 - $\int_{-\infty}^{\infty} \delta(t) dt = 1$
 - $\int \frac{d}{dt} u(t) = \delta(t)$

Convolution

- ODE methods are tedious for large circuits, so use convolution
- Convolution relates inputs (excitations) to ~~outputs~~ outputs (responses) using a circuit model operated on by the input functions.

Get the out



- Convolution $\circ \ast$ $f(t) \ast g(t) = \int_{-\infty}^{\infty} f(\tau) g(t-\tau) d\tau$ or (for a impulse) $= \int_0^t f(\tau) g(t-\tau) d\tau$ (shown below)
 ~ moving g reflected across y across the graph. area of intersection is $f(t) \ast g(t)$

- $x(t) \ast \delta(t) = x(t) \Rightarrow x(t) \ast \delta(t) = \int_{t_0}^{t_0} x(t) \delta(t_0-t) dt = x(t_0)$

- Time shifting: $x(t) \ast \delta(t-T) = x(t_0) \ast \int_{t_0}^{t_0+T} \delta(t_0-t) dt$
- $y(t) = x(t) \ast u(t) = \int_{-\infty}^{\infty} x(\tau) u(t-\tau) d\tau$

$$x(t) u(t) \ast u(t) = \int_0^t x(\tau) d\tau u(t)$$

Alg props:

$$f(t) \ast g(t) = g(t) \ast f(t)$$

$$[f(t) \ast g(t)] \ast h(t) = f(t) \ast [g(t) \ast h(t)]$$

$$f(t) \ast [g(t) \ast h(t)] = f(t) \ast g(t) + f(t) \ast h(t)$$

- converting time domain
set it so unit step is
where the top bound
= bottom bound.

Time shifting
Simple:

$$x(t) \ast \delta(t-T) = x(t-T)$$

Discrete Convolution

$$u[n] = \begin{cases} 0 & n < 0 \\ 1 & n \geq 0 \end{cases} \quad \delta[n] = \begin{cases} 0, & n \neq 0 \\ 1, & n = 0 \end{cases} \quad \text{where } n \in \mathbb{Z}$$

$$f[n] * g[n] = \sum_{m=-\infty}^{\infty} f[m] g[n-m]$$

- Uses same graphical shift as regular conv.
- Same alg. properties as reg. conv
- Convert complex scenes into discrete



Max spacing = 0.2 (FWHM)

Preferred = 0.1 (FWHM)

where FWHM is width at 50% amp.

Preferred extension of peak tails = 20 (FWHM)

Accuracy with Δt time intervals.

Impulse Response

• Linear Time Invariant Systems (LTIs)

- produce output signals related to inputs linearly + time invariantly

- Diagram:



or $y(t) = x(t) * h(t)$

- Using $x(t) = \delta(t)$, we can find $h(t)$.

- * $y(t) = \delta(t) * h(t) = h(t)$

- * $h(t)$ is the Impulse Response

- The ODEs for RLC circuits give us the step response.

- To find impulse response from step response, take the derivative of the step response.

- $v_{in} = u(t)$ to find step response.

$$i_{in} = u(t)$$

Laplace Transformations

- Transforms from time domain to frequency domain (Riggs)
- Reciprocal of time is frequency. Can solve in freq and convert back
- One sided Laplace Transform:

$$\mathcal{L}\{f(t)\} = F(s) = \int_0^\infty f(t) e^{-st} dt$$

where s is the complex frequency. $s = \sigma + j\omega$

- Laplace Transforms of functions:

$$\mathcal{L}\{\delta(t)\} = 1$$

$$\mathcal{L}\{\delta(t-t_0)\} = e^{-st_0}$$

$$\mathcal{L}\{u(t)\} = \frac{1}{s} \quad \leftarrow s > 0$$

Properties

$$\mathcal{L}\left\{\frac{d}{dt} f(t)\right\} = sF(s) - f(0^-)$$

$$\mathcal{L}\left\{\frac{d^2}{dt^2} f(t)\right\} = s^2 F(s) - sf(0^-) - \frac{df(0)}{dt}$$

$$\mathcal{L}\left\{\int_{-\infty}^t f(\tau) d\tau\right\} = \frac{F(s)}{s} + \frac{\int_{-\infty}^0 f(\tau) d\tau}{s}$$

$$\mathcal{L}\{af(t) + bg(t)\} = aF(s) + bG(s)$$

$$\mathcal{L}\{\delta(t-t_0)\} = e^{-st_0} F(s) \quad \leftarrow \text{Time shift}$$

$$\mathcal{L}\{e^{-at} f(t)\} = F(s+a) \quad \leftarrow \text{Freq. shift}$$

$$\mathcal{L}\{f(t) * g(t)\} = F(s) G(s)$$

$$\mathcal{L}\{t^n f(t)\} = (-1)^n \frac{d^n}{ds^n} F(s)$$

- Use PFD to decompose fractions for inverse LT.

- Actual formula rarely used:

$$\frac{1}{j2\pi} \oint_P F(s) e^{st} ds$$

- Final Value Theorem

$$\lim_{t \rightarrow \infty} f(t) = f(\infty) = \lim_{s \rightarrow 0} sF(s)$$

Remember
Upper Case
is replaced

Current - Voltage Rel.
in S-domain (freq. domain)

- Regular Response is applicable for any time
- Zero-State Response is when initial cond. are zero.

	Reg Resp.	Zero-State
Resistors		
$V_R(s)$	$R I_R(s)$	$R I_R(s)$
$I_R(s)$	$G V_R(s)$	$G V_R(s)$
Inductors		
$V_L(s)$	$L(sI_L(s) - i_L(0))$	$sLI_L(s)$
$I_L(s)$	$\frac{1}{L} \left(\frac{V_L(s)}{s} + \frac{\int_0^\infty v_L(\tau) d\tau}{s} \right)$	$\frac{1}{sL} V_L(s)$
Capacitors		
$V_C(s)$	$\frac{1}{C} \left(\frac{I_C(s)}{s} + \frac{\int_0^\infty i_C(\tau) d\tau}{s} \right)$	$\frac{1}{sC} I_C(s)$
$I_C(s)$	$C(sV_C(s) - v_C(0))$	$s(V_C(s))$

- Impedance can be defined as

$$Z(s) = \frac{V(s)}{I(s)}$$

Admittance is

$$Y(s) = \frac{1}{Z(s)}$$

- This means:

and

Admittance!

$$\begin{aligned} Z_R &= R \\ Z_L &= sL \\ Z_C &= \frac{1}{sC} \end{aligned}$$

$$\begin{aligned} Y_R &= G \\ Y_L &= \frac{1}{sL} \\ Y_C &= sC \end{aligned}$$

- We can do this to solve odes. Use Impedances to find V/I in S-domain, and use inverse Laplace to get the time domain equations.

Initial Conditions

- Capacitor initial conditions.

$$I_C(s) = C(sV_C(s) - V_C(0^-))$$

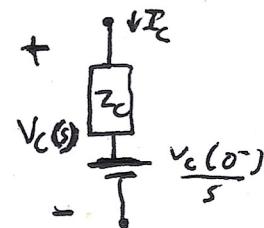
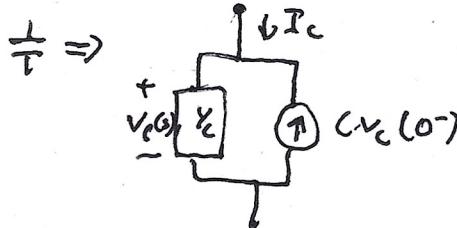
$$Y_C = sC$$

$$\Downarrow I_C(s) = V_C(s)Y_C(s) - (V_C(0^-))$$

or

$$V_C(s) = I_C(s)Z_C(s) + \frac{V_C(0^-)}{s}$$

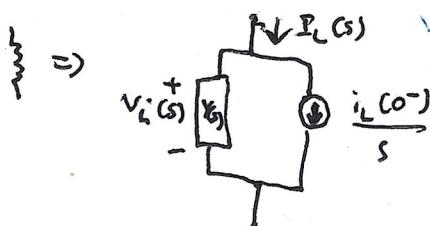
$$Z_C = \frac{1}{sC}$$



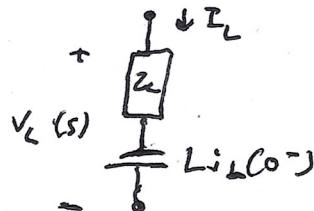
- Inductor initial conditions

$$I_L(s) = V_L(s)Y_L(s) + \frac{i_L(0^-)}{s}$$

$$Y_L = \frac{1}{sL}$$



$$\text{or } V_L(s) = I_L(s)Z_L(s) - L\dot{i}_L(s)$$



- Use series model ~~also~~ when circuit is series and parallel model when circuit is parallel.
- Use superposition to calculate voltages across impedances (calc with source and with init. cond. separately). Then use initial condition to find properties across the component.
- Complete Response = Zero-Input Resp. (ZIR) + Zero-State Resp. (ZSR)
 - ZIR - Response to init. cond. + turning off all inputs.
 - ZSR - Response to input sig. + turning off all init. cond.
 - Forced Resp. - Resp. from components not assoc. w/ natural freq (aka roots of char. eq.)
 - Natural Resp. - Resp. from components assoc. w/ natural freq
 - Transient Resp. - Resp. that changes w/ time (No sinusoidal/constant)
 - Sinusoidal Steady State Resp. - Resp. that is sinusoidal w/ time.

Transfer Function

- From $y(t) = h(t)*x(t) \Rightarrow Y(s) = H(s)X(s)$
Out \uparrow In \uparrow
- Dependins on the question, voltage current vars can be assigned to $Y(s)$ or $X(s)$. We find $H(s)$ by finding $Y(s)$ when $X(s) = 1$ and using $H(s) = \frac{Y(s)}{X(s)} \stackrel{X(s)=1}{=} Y(s) \Rightarrow H(s) = Y(s)$.
 - Initial condns = 0 (No stored energy)
 - No Indep. Sources.

The Complexity Plane
+
Stability

- Imped. + Admit. Transfer Functions are rational funns:

$$H(s) = \frac{P(s)}{Q(s)} = \frac{a_0 + a_1 s + a_2 s^2 + \dots + a_m s^m}{b_0 + b_1 s + b_2 s^2 + \dots + b_n s^n} \quad (m \leq n)$$

$$H(s) = K \frac{(s - z_1)^{q_1} (s - z_2)^{q_2} \dots (s - z_m)^{q_m}}{(s - p_1)^{r_1} (s - p_2)^{r_2} \dots (s - p_n)^{r_n}}$$

p_n are the poles of $H(s)$, r_n is order of repeated poles

z_n are the zeroes of $H(s)$, q_m is order of repeated zeroes

K is the gain constant

- Once $H(s)$ is found, response to any input can be calced (if their var is the same)
- Trans. func. shows info of system through its form.
- Freq: Resp $s = j\omega$ or $s = \sigma + j\omega$ (remember $\omega_0 = \frac{1}{\sqrt{LC}}$ Radius)
- X -pole, 0 -zeroes (the damping circle)
- Poles Show nat. response, $H(s)$ inverse laplace is nat. response
- order of pole > 1 , multiply term by t^n (~~so it's not zero for $t=0$~~)
- When doing inverse laplace, we can tell stability.
 - If order of pole > 1 ($A(t) + B(t)$), unstable, else ($A(t)$) stable. ($\frac{A}{s}$ or $\frac{A}{s^k}$)
 - $p_i > 0 \Rightarrow$ unstable, $p_i < 0 \Rightarrow$ stable ($\frac{A}{s-p_i}$)
 - $p_i < 0 \Rightarrow$ stable ($\frac{A}{s-p_i} K$)
 - Marginally stable ($\frac{A(s)+B}{s^{2m+2}}$)
 - $a > 0 \Rightarrow$ stable, $a < 0 \Rightarrow$ unstable ($\frac{A(s)+B}{(s+a)^2 + \omega^2}$)

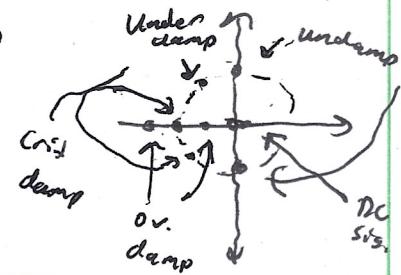
The Complexity Plane + Stability Contd

- Bounded input, bounded output Stability (BIBO)

- Sols have to be bounded for stability

Means $\int_{-\infty}^{\infty} |x(t)| dt < K_I < \infty$ Max vals

\rightarrow Out: $\int_{-\infty}^{\infty} |y(t)| dt < K_O < \infty$



- BIBO is assured if all poles $\sigma_i < 0$ (left) stability
- ~~Unstable~~ Unstable if any pole $\sigma_i > 0$
- Order 1 poles + $\sigma_i = 0$ are marg. stable
- Order 2+ poles + $\sigma_i = 0$ are unstable

- Zeroes show where the output will only be natural resp. not natural + forced.

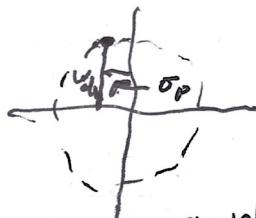
Resonance

- RLC circuit is in resonance when the voltage and current are in phase at the input terminals.

- σ_p is exp. attenuation factor (real part)

- w_d is damped res. freq. (im. part)

$$\omega_0 = \sqrt{\omega_d^2 + \sigma_p^2} = \frac{1}{\sqrt{LC}}$$



• Phasor method: replace $s = j\omega$

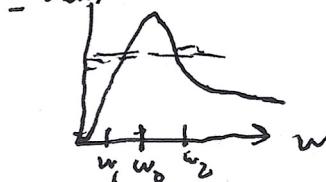
• ω_r is freq. when imp/adm. becomes purely real. Resonance frequency

\rightarrow (cancels loss) $\omega_r = \omega_0$ IN SIMPLE CIRCUITS

- Max Voltage is prop. to resistance, all curr. flows through resistor.

- Bandwidth $\Rightarrow B_w = \omega_2 - \omega_1$, where ω_2 and ω_1 are

Frequencies where volt = max $V = \frac{1}{\sqrt{2}}$



- Phase angle: $\phi = \tan^{-1} \frac{\omega_0}{\omega}$

- To convert an algebraic phasor into phasor form do this $\sigma + j\omega \Rightarrow \sqrt{\sigma^2 + \omega^2} \angle \tan^{-1} \left(\frac{\omega}{\sigma} \right)$

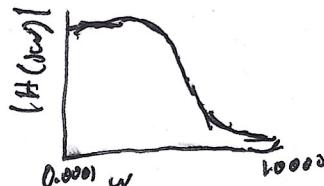
$$\text{ex. } Z(iw) \Rightarrow |Z(iw)| \angle \tan^{-1} \left(\frac{\omega}{\sigma} \right) \Rightarrow |Z(iw)| \angle \phi$$

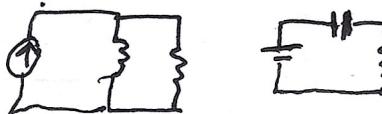
- We can graph changes in the phasor while changing ω . There are two graphs, $|Z(iw)|$ vs ω and ϕ vs ω which sets up phasor from frequency.

- Bode Plots approx. mag plots:

$$|H(i\omega)|_{dB} = 20 \log_{10} |H(i\omega)|$$

- $\omega = 2 \text{ rad/s}$ is cutoff/half-power freq. between low freq. & high freq.



Filter Basics

High pass filters

- Allows \uparrow freq.

Low pass filters

- Allows \downarrow freq.

- $|H(j\omega)|_{dB} > 0 \Rightarrow$ Amplification, $< 0 \Rightarrow$ Attenuation.

- $(s+2) \Rightarrow (s+w_p)$ where w_p is ang. freq. at pole
- Convention is $(s+2) \Rightarrow 2\left(\frac{s}{2} + 1\right) \Rightarrow 2\left(\frac{s}{w_p} + 1\right)$

Bode Plots

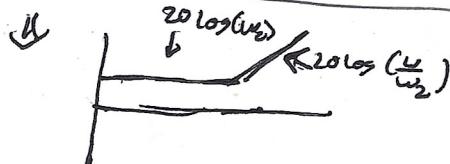
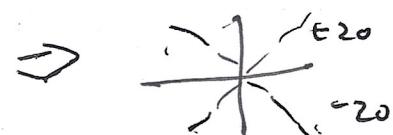
$$|H(s)| = s = \omega \Rightarrow |H(j\omega)|_{dB} = 20 \log(\omega)$$

$$|H(s)| = \frac{1}{s} = \frac{1}{\omega} \Rightarrow |H(j\omega)|_{dB} = -20 \log(\omega)$$

$$H(s) = (s+2) \Rightarrow H(j\omega) = w_2 \left(1 + \frac{j\omega}{w_2}\right)$$

$$\Rightarrow |H(j\omega)|_{dB} = 20 \log(w_2) \quad \omega \rightarrow 0$$

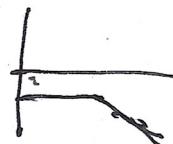
$$|H(j\omega)|_{dB} = 20 \log(w_2) + 20 \log\left(\frac{\omega}{w_2}\right) \quad \omega \rightarrow \infty$$



$$H(s) = \frac{1}{s + p} \Rightarrow |H(j\omega)|_{dB} = -20 \log(w_p) - 20 \log\left[\sqrt{1^2 + \frac{\omega^2}{w_p^2}}\right]$$

$$|H(j\omega)|_{dB} = -20 \log(w_p) \quad \omega \rightarrow 0$$

$$|H(j\omega)|_{dB} = -20 \log(w_p) + 20 \log\left(\frac{\omega}{w_p}\right) \quad \omega \rightarrow \infty$$



Bode plots

$$\bullet H(s) = K \frac{(s-z_1)(s-z_2)\dots(s-z_m)}{(s-p_1)(s-p_2)\dots(s-p_n)} \Rightarrow H(j\omega) = K \frac{(j\omega-z_1)(j\omega-z_2)\dots(j\omega-z_m)}{(j\omega-p_1)(j\omega-p_2)\dots(j\omega-p_n)}$$

↓

$$|H(j\omega)| = K \frac{\prod_{k=1}^m |j\omega - z_k|}{\prod_{l=1}^n |j\omega - p_l|}$$

$$\angle H(j\omega) = \sum_{k=1}^m \angle(j\omega - z_k) - \sum_{l=1}^n \angle(j\omega - p_l)$$

Magnitude & Frequency Scaling

- Multiply Impedance by K_m { divide C by K_m }
 - Includes curr. controlled sources
 - Divide by K_m for voltage controlled sources } ← Mag Scaling
- This results in no change in zeroes or poles
 - $|H|$ could change.
- H has no change for dimensionless $H(s)$ (simple $\frac{Z_o}{Z_{in}}$)

• Resistors are not freq. scaled
 • $L_{new} = \frac{L_{old}}{K_g}$
 • $C_{new} = \frac{C_{old}}{K_g}$

• $H(s)_{new} = H\left(\frac{s}{K_g}\right)$
 • $K_g > 1 \uparrow$ peak width, $K_g \downarrow$ peak width

\uparrow
 Freq.
 scaling.

Bandpass Response

• Voltage Response Properties.

- Max V is prop. to resistance

$$\propto Z_{in}(j\omega) = R \text{ @ } \omega = \omega_r$$

- All current flows through R @ $\omega = \omega_r$

- Width of response depends on R, L, C

Shapeness or peak \rightarrow Quality Factor $\Rightarrow Q = \frac{\omega_m}{B_w} = \frac{\omega_m}{B_w}$

$$\propto \text{Bandwidth } B_w = \omega_H - \omega_L$$

- H_m - max of transfer func, ω_m - when $|H(j\omega)| = H_m$

$$\begin{aligned} \omega_H &= \sqrt{\left(\frac{1}{2RC}\right)^2 + \frac{1}{LC}} + \frac{1}{2RC} \\ \omega_L &= \sqrt{\left(\frac{1}{2RC}\right)^2 + \frac{1}{LC}} - \frac{1}{2RC} \end{aligned} \quad \begin{aligned} \omega_H &= \omega_m + \frac{B_w}{2} \\ \omega_L &= \omega_m - \frac{B_w}{2} \end{aligned}$$

$$B_w \approx \omega_H - \omega_L = \frac{1}{RC}$$

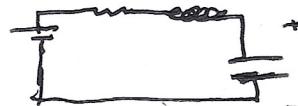
$$Q = \frac{\omega_m}{B_w} = \omega_0 RC$$

\Leftrightarrow Specific to parallel

$$B_w = \frac{R}{L}$$

$$Q = \omega_0 \frac{L}{R}$$

\Leftrightarrow Specific to series



$$H_m = \frac{1}{R}$$

$$\omega_H = \omega_m + \frac{B_w}{2}$$

$$\omega_L = \omega_m - \frac{B_w}{2}$$



Passive Low Pass Filters

- Higher order = faster cutoff.
- First order:

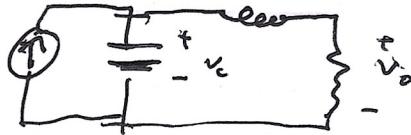


$$H(j\omega) = \frac{1}{1+j\omega C R}$$

- Second order

$$H(s) = 2 \text{ in } (s)$$

ω_c - corner freq of the zero.



- Filter characterization

- Analysis

✗ Define $H(s)$

✗ Convert to SSS $s = j\omega \Rightarrow H(j\omega)$

✗ Construct Mag. Fig. $|H(j\omega)|$

- Steps

✗ Specify type: (high, low, band pass,

✗ Construct transfer func.

✗ Design Circuit.

Butterworth LPF

- Transfer function

$$|H(j\omega)| = \frac{K}{\sqrt{1 + (\frac{\omega}{\omega_c})^{2n}}}$$

$\omega_c = \omega_{3dB}$ - corner freq

n = filter order

K = constant

- Normalized B LPF Transfer functions. ($K=1, \omega_c = 1 \text{ rad/s}$)

• $n=1 \quad H(s) = \frac{1}{s+1}$

• $n=2 \quad H(s) = \frac{1}{s^2 + 2s + 1}$

• $n=3 \quad H(s) = \frac{1}{s^3 + 3s^2 + 2s + 1}$

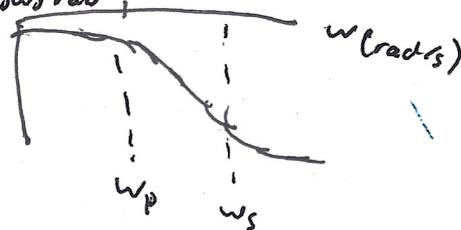
• $|A(\omega)|_{dB} = 20 \log |H(j\omega)|_{dB}$

ω_p - pass band

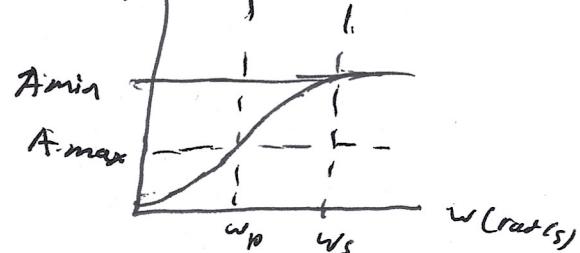
• $A(\omega)_{dB} = -20 \log |H(j\omega)|_{dB}$

ω_s - stop band

$|H(j\omega)|_{dB}$



$|A(\omega)|_{dB}$



- Filter design steps. Design specifications:
- use normalized
- Find filter order $[\frac{\omega_s}{\omega_c}]^{2n} \geq 10^{0.1 A_{max}}$
 - Select transfer function
 - Select circuit structure
 - Find t adjust ω_c if $A_{max} \neq 3dB$ ($\omega_c = \omega_p$ if $A_{max} = 3dB$)
 - Magnitude + freq. Scale as needed

$$\left\{ \begin{array}{l} A_{max}, A_{min}, \\ \omega_p, \omega_s \end{array} \right\}$$

1. $n_{min} \geq \frac{\log \left(\frac{10^{0.1 A_{max}} - 1}{10^{0.1 A_{min}} - 1} \right)}{2 \log \left(\frac{\omega_s}{\omega_p} \right)}$

(Select first int min)



2. Choose transfer from normalized options

3. If source R_s is known, add $1/R_s$ in series w/ filter and use
If load R_L is known, add $1/R_L$ in parallel w/ filter $\xrightarrow{\text{mag scaling}}$

4. ω_c is half power freq.,

$$\frac{\omega_p}{(10^{0.1 A_{max}} - 1)^{\frac{1}{2n}}} \leq \omega_c \leq \frac{\omega_s}{(10^{0.1 A_{min}} - 1)^{\frac{1}{2n}}}$$

Butterworth HPF

- HPF Design
 - Convert HPF to LPF
 - Design Butterworth LPF
 - Convert LPF to HPF
 - × C to L and L to C
 - × freq + mas scaling.

1. $w < w_p \quad A < A_{max}$
 $w > w_s \quad A < A_{min}$ \Rightarrow $w < w_s \quad A > A_{min}$
 $w > w_p \quad A < A_{max}$

$r = \frac{w_p}{\omega} \rightarrow R_p = \frac{w_p}{w_p} = 1, \quad R_s = \frac{w_p}{sw_s} > 1$

2. Replace all w_s , w_p , r_s .

3.

$C_{LPF} \rightarrow L_{HPF} = \frac{1}{C_{LPF}}$
 $L_{LPF} \rightarrow C_{HPF} = \frac{1}{L_{LPF}}$

Active LPF

• Passive -

- Requires Inductor ($> 2^{\text{nd}}$ order) which is most non-ideal element

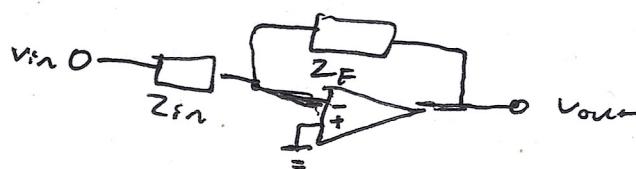
- Passband gain $< 0 \text{ dB}$ (other than peaking)

• Active

- Can avoid Inductors

- Pass band gain $> 0 \text{ dB}$

• Op-Amp LPFs



$$\Rightarrow H(s) = \frac{V_{\text{out}}}{V_{\text{in}}} = -\frac{Z_f(s)}{Z_{\text{in}}(s)}$$